SDLS055

## SN54153, SN54LS153, SN54S153 SN74153, SN74LS153, SN74S153 DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

DECEMBER 1972 - REVISED MARCH 1988

- Permits Multiplexing from N lines to 1 line
- Performs Parallel-to-Serial Conversion
- Strobe (Enable) Line Provided for Cascading (N lines to n lines)
- High-Fan-Out, Low-Impedance, Totem-Pole Outputs
- Fully Compatible with most TTL Circuits

Type		YPICAL AVER		TYPICAL
TYPE	FROM DATA	GATION DELA FROM STROBE	FROM SELECT	POWER DISSIPATION
153	14 ns	17 ns	22 ns	180 mW
LS153	14 ns	19 ns	22 ns	31 mW
<b>'S153</b>	6 ns	9.5 ns	12 ns	225 mW

#### description

Each of these monolithic, data selectors/multiplexers contains inverters and drivers to supply fully complementary, on-chip, binary decoding data selection to the AND-OR gates. Separate strobe inputs are provided for each of the two four-line sections.

#### **FUNCTION TABLE**

ł	ECT UTS		DATA	INPUT:	s	STROBE	OUTPUT
В	А	CO	C1	C2	C3	Ğ	Y
×	×	Х	X	Х	Х	н	i i i L
) L	L	L	X	X	X	L	L
L	L	Н	Х	X	X	- P. C	н
L	Н	Х	L	×	×	L.	L
L	Н	X	н	х	×	L	н
н	L	х	х	L	х	L	L
Н	L	х	Х	Н	х	L	н
н	Н	х	Х	Х	Ļ	L	
н	_ н	Х	x_	Х	н	L	н

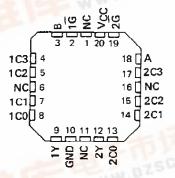
Select inputs A and B are common to both sections.

H = high level, L = low level, X = irrelevant

#### SN54153, SN54LS153, SN54S153... J OR W PACKAGE SN74153... N PACKAGE SN74LS153, SN74S153... D OR N PACKAGE (TOP VIEW)

1G	1	U <sub>16</sub>	□ vcc
вС	2	15	🖺 2G
1C3 [	]3	14	□ A
1C2	4	13	2C3
1C1 🗌	5	12	2C2
1 CO 🗀	6	11	2C1
1Y 🗆	7	10	2C0
GND [	8	9	] 2Y

## SN54LS153, SN54S153 . . . FK PACKAGE (TOP VIEW)

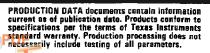


NC - No internal connection

#### absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (See Note 1)			7 V	/
Input voltage: '153, 'S153			5.5 ∨	/
LS153			7 V	,
Operating free-air temperature range:	SN54'	- 55°C	to 125°C	:
	SN74',,	o°C	C to 70°C	;
Storage temperature range		- 65°C	to 150°C	

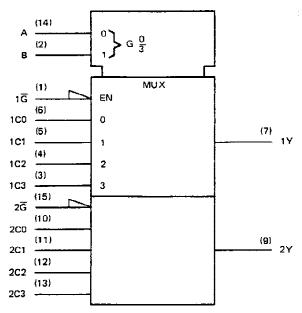
NOTE 1: Voltage values are with respect to network ground terminal.



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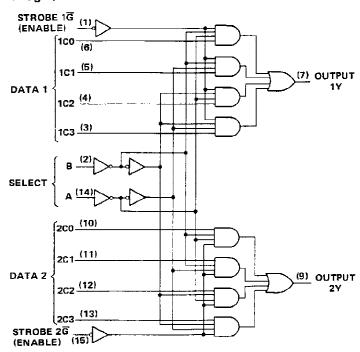


## logic symbol†



<sup>&</sup>lt;sup>†</sup>This symbol is in accordance with ANSI/IEEE Std. 91-1984 and IEC Publication 617-12.

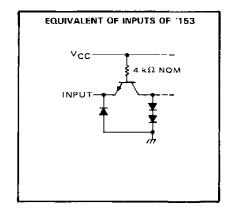
#### logic diagrams (positive logic)

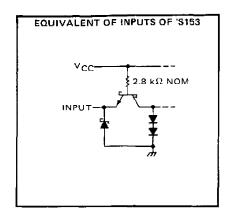


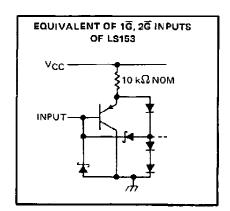
Pin numbers shown are for D, J, N, and W packages.

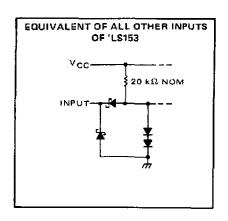


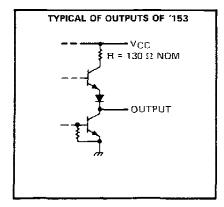
### schematics of inputs and outputs

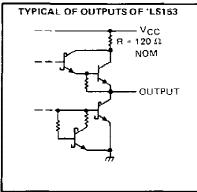


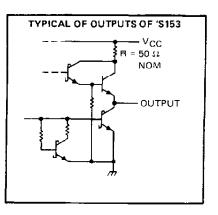












## SN54153, SN74153 **DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS**

#### recommended operating conditions

		SN54153			SN74153		
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
Supply voltage, V <sub>CC</sub>	4.5	5	5.5	4.75	5	5.25	V
High-level output current, IOH			-800			-800	μА
Low-level output current, IOL			16		•	16	mA
Operating free-air temperature, TA	-55		125	0		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEGT COMPUTER ST		SN5415	3		SN7415	3	UNIT
	PARAMETER	TEST CONDITIONS <sup>†</sup>	MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage		2			2			٧
VIL	Low-level input voltage				8.0			8.0	٧
VIK	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>1</sub> = -12 mA			-1.5			-1.5	V
Voн	High-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OH</sub> = -800 μA	2.4	3.4		2.4	3.4		٧
VOL	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 16 mA		0.2	0.4		0.2	0.4	٧
11	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V			1			1	mΑ
ЧH	High-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 2.4 V			40			40	μА
IIL.	Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V			-1.6			-1.6	mA
los	Short-circuit output current §	V <sub>CC</sub> = MAX	-20		-55	18	<del></del>	-57	mA
ICCL	Supply current, output fow	V <sub>CC</sub> = MAX, See Note 2		36	52		36	60	mA

<sup>\*</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics, VCC = 5 V, TA = 25°C

2424457504	FROM	то	TEST CONDITIONS	MIN	TYP	MAAV	UNIT	
PARAMETER¶	(INPUT) (OUTPUT		TEST CONDITIONS	101010	117	MAY	UNIT	
tPLH	Data	Y			12	18	ns	
tPHL	Data	Υ "	7		15	23	ns	
tPLH	Select	Y	C <sub>L</sub> = 30 pF, R <sub>L</sub> = 400 Ω,		22	34	ns	
<sup>t</sup> PHL	Select	Y	See Note 3		22	34	⊓\$	
<sup>†</sup> PLH	Strobe G	Y			19	30	กร	
tent	Strobe G	Y	7		15	23	กร	

 $<sup>\</sup>P_{tPLH}$  = propagation delay time, low-to-high-level output

 $<sup>^{\</sup>ddagger}$ All typical values are at  $^{\lor}$ CC = 5  $^{\lor}$ ,  $^{\lor}$ A = 25 $^{\circ}$ C.  $^{\S}$ Not more than one output should be shorted at a time.

NOTE 2:  $I_{\mbox{CCL}}$  is measured with the outputs open and all inputs grounded.

tpHL = propagation delay time, high-to-low-level output

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

## SN54LS153, SN74LS153 DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

#### recommended operating conditions

	S	N54LS1	53	S	53	LIBILT	
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT
V <sub>CC</sub> Supply voltage	4.5	5	5,5	4.75	5	5.25	V
VIH High-level input voltage	2			2			٧
VIL Low-level input voltage			0.7			0.8	V
IOH High-level output current			- 0.4			- 0.4	mΑ
IOL Low-level output current			4			8	mΑ
TA Operating free-air temperature	55		125	Ö		70	°C

## electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †		SN54LS	153	s	N74LS1	53	
PANAMETER	TEST CONDITIONS I	MI	N TYP	MAX	MIN	TYP‡	MAX	UNIT
Vik	V <sub>CC</sub> = MIN, I <sub>1</sub> = - 18 mA			- 1.5			- 1.5	V
V <sub>OH</sub>	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, V <sub>IL</sub> = MAX I <sub>OH</sub> = -0.4 mA	2.	5 3.4		2,7	3.4	•	٧
VOL	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, I <sub>OL</sub> =	4 mA	0.25	0.4		0.25	0.4	v
VOL	VIL = MAX, IOL =	8 mA				0.35	0.5	) V
14	VCC = MAX, VI = 7 V			0.1			0.1	mΑ
l <sub>IH</sub>	V <sub>CC</sub> = MAX, V <sub>1</sub> = 2.7 V			20			20	μА
1G, 2G	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.4 V		-	- 0.2			- 0.2	mΑ
All other	VCC - MAX, VI - 0.4 V			- 0.4			- 0.4	IIIA
los §	VCC = MAX	- 2	0	<b>–</b> 100	<b>– 20</b>		- 100	mΑ
1ccr	V <sub>CC</sub> = MAX, See Note 2		6.2	10		6.2	10	mД

<sup>†</sup> For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

NOTE 2: ICCL is measured with the outputs open and all inputs grounded.

## switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	MAX	UNIT
tрLН	Data	Y			10	15	ns
tPHL.	Data	Y	C <sub>L</sub> = 15 pF,		17	26	п\$
<sup>t</sup> PLH	Select	Y	$R_{L} = 2 k\Omega$ ,		19	29	пѕ
tPHL	Select	Y	See Note 3		25	38	ns
tPLH	Strobe G	Y	366 14016 3		16	24	ns
†PHL	Strobe G	Y		l	21	32	ns

 $<sup>\</sup>P_{tpLH}$  = propagation delay time, low-to-high-level output

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

<sup>‡</sup> All typical values are at  $V_{CC}$  = 5 V,  $T_A$  = 25°C.

<sup>§</sup>Not more than one output should be shorted at a time.

tpHL = propagation delay time, high-to-low-level output

# SN54S153, SN74S153 DUAL 4-LINE TO 1-LINE DATA SELECTORS/MULTIPLEXERS

#### recommended operating conditions

	s	SN54S153			SN74S153		
	MIN	NOM	MAX	MIN	NOM	MAX	דומט
Supply voltage, VCC	4.5	5	5.5	4.75	5	5.25	٧
High-level output current, IOH			-1			-1	mΑ
Low-level output current, IOL			20			20	mΑ
Operating free-air temperature, TA	-55		125	0		70	,C

### electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	PARAMETER	TEST CONDITIONS†	MIN	TYP‡	MAX	UNIT
VIH	High-level input voltage		2			٧
VIL	Low-level input voltage				0.8	٧
Vικ	Input clamp voltage	V <sub>CC</sub> = MIN, I <sub>1</sub> = -18 mA			-1.2	٧
	111-b lovel output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V, Series 545	2.5	3.4		V
νон	High-level output voltage	V <sub>IL</sub> = 0.8 V, IOH = -1 mA Series 74\$	2.7	3.4		٧
·	Low-level output voltage	V <sub>CC</sub> = MIN, V <sub>IH</sub> = 2 V,		_	0.5	V
VOL	Low-level output voltage	V <sub>IL</sub> = 0.8 V, I <sub>OL</sub> = 20 mA		°		_
ų	Input current at maximum input voltage	V <sub>CC</sub> = MAX, V <sub>I</sub> = 5.5 V			1]	mΑ
IН	High-level input current	V <sub>CC</sub> = MAX, V <sub>1</sub> = 2.7 V			50	μA
HL	Low-level input current	V <sub>CC</sub> = MAX, V <sub>I</sub> = 0.5 V			-2	mA
los	Short-circuit output current §	V <sub>CC</sub> = MAX	-40		-100	mΑ
CCL	Supply current, low-level output	V <sub>CC</sub> = MAX, See Note 2		45	70	mΑ

<sup>&</sup>lt;sup>†</sup>For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

## switching characteristics, VCC = 5 V, TA = 25°C

PARAMETER¶	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP	МАХ	UNIT
tPLH	Data	Y	C <sub>L</sub> = 15 pF, R <sub>L</sub> = 280 Ω, See Note 3		6	9	ns
tPHL	Data	Y			6	9	ns
tPLH .	Select	Y			11.5	18	пѕ
tPHL_	Select	Y			12	18	ns
фен	Strobe G	Y			10	15	пв
tpнL,	Strobe Ĝ	Y			9	13.5	กร

 $<sup>\</sup>P_{tpLH}$  = propagation delay time, low-to-high-level output

<sup>‡</sup>All typical values are at  $V_{CC} \approx 5 \text{ V}$ .  $T_A = 25^{\circ}\text{C}$ .

 $<sup>\</sup>S$  Not more than one output should be shorted at a time and duration of short circuit should not exceed one second.

NOTE 2: ICCL is measured with the outputs open and all inputs grounded,

tpHL = propagation delay time, high to-low level output

NOTE 3: Load circuits and voltage waveforms are shown in Section 1.

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